Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination OKAMOTO ET AL. Examiner Tae H Yoon Applicant(s)/Patent Under Reexamination OKAMOTO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | Α | US-5,408,347 | 04-1995 | Murakami et al. | 349/132 |
| | В | US-5,508,069 | 04-1996 | Jin, Sung-ho | 428/1.2 |
| | С | US-5,943,110 | 08-1999 | Yoda et al. | 349/134 |
| | D | US- | | | |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
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| | 0 | | | | | |
| | Р | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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